

FDPF3860T

N-Channel PowerTrench[®] MOSFET 100V, 20A, 38.2m Ω

Description

- $R_{DS(on)} = 38.2 \text{m}\Omega$ (MAX) @ $V_{GS} = 10 \text{V}$, $I_D = 5.9 \text{A}$
- · Fast switching speed
- · Low gate charge
- High performance trench technology for extremely low R_{DS(on)}
- · High power and current handling capability
- RoHS compliant



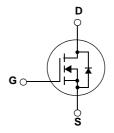
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

• DC to AC converters / Synchronous Rectification





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		Parameter		Ratings	Units
V_{DSS}	Drain to Source Voltage			100	V
V_{GSS}	Gate to Source Voltage			±20	V
	Drain Current	- Continuous (T _C = 25°C)		20	^
ID	Drain Current	- Continuous (T _C = 100°C)		12.7	Α
I _{DM}	Drain Current - Pulsed		(Note 1)	80	Α
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	278	mJ
I _{AR}	Avalanche Current		(Note 1)	20	Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	3.4	mJ
dv/dt	Peak Diode Recovery dv/d	t	(Note 3)	15	V/ns
6	Davier Dissipation	$(T_C = 25^{\circ}C)$		33.8	W
P_{D}	Power Dissipation	- Derate above 25°C		0.27	W/°C
T _J , T _{STG}	Operating and Storage Ten	nperature Range		-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

Thermal Characteristics

Symbol	Parameter Ratings			
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.7	°C/W	
R _{e,IA}	Thermal Resistance, Junction to Ambient	62.5	-C/VV	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPF3860T	FDPF3860T	TO-220F	-	-	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A, V_{GS} = 0V, T_J = 25^{\circ}C$	100	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.1	=	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 80V, V_{GS} = 0V$	-	-	1	μА
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 48V, T_{C} = 150^{\circ}C$	-	-	500	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	2.5	-	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 5.9A$	ı	29.1	38.2	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 10V, I_D = 5.9A$ (Note 4)	-	21	=	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V/ 05V/ V/ 0V/	-	1350	1800	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz	-	145	190	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/12	-	60	90	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	15	40	ns
t _r	Turn-On Rise Time	$V_{DD} = 50V, I_{D} = 5.9A$		-	17	45	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 6\Omega$		-	24	60	ns
t _f	Turn-Off Fall Time		(Note 4, 5)	-	7	25	ns
Q _{g(tot)}	Total Gate Charge at 10V			-	23	35	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 80V, I_{D} = 5.9A$		-	7	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V	(Note 4, 5)	-	8	-	nC

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current			-	-	20	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	80	Α	
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 5.9A$		-	-	1.3	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_{SD} = 5.9A$		-	40	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	56	-	nC

Notes:

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L =16mH, I_{AS} = 5.9A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 3. $I_{SD} \le 5.9 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \, \text{Duty Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

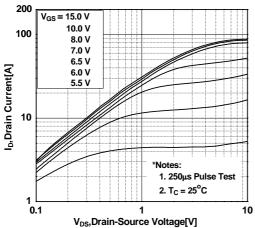


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

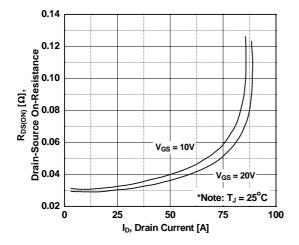


Figure 5. Capacitance Characteristics

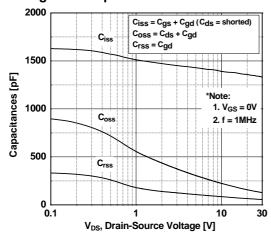


Figure 2. Transfer Characteristics

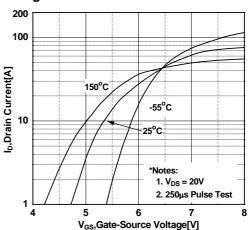


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

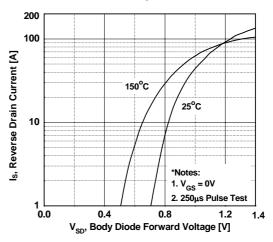
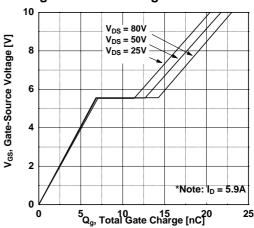


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

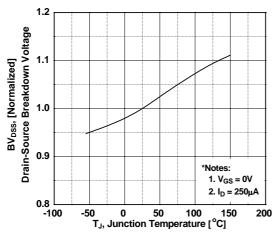


Figure 9. Maximum Safe Operating Area

Figure 8. On-Resistance Variation vs. Temperature

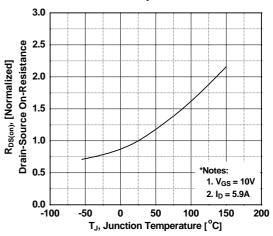
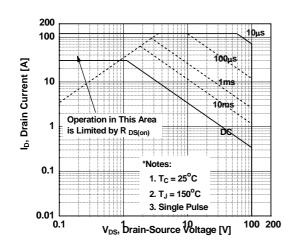


Figure 10. Maximum Drain Current vs. Case Temperature



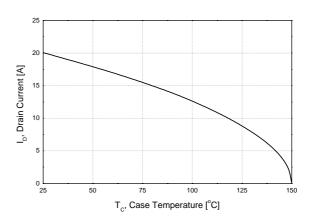
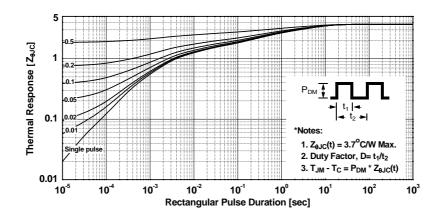
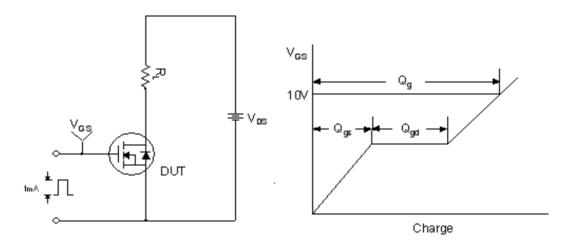


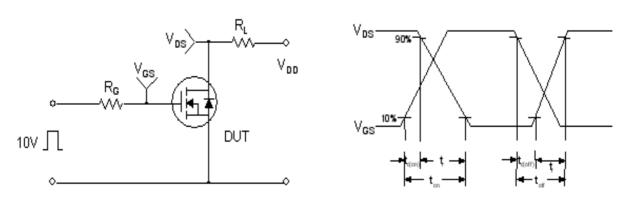
Figure 11. Transient Thermal Response Curve



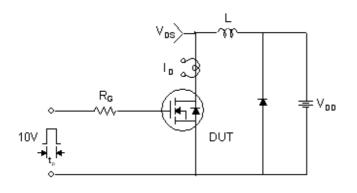
Gate Charge Test Circuit & Waveform

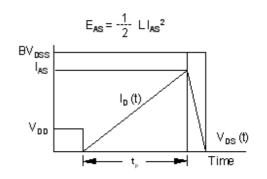


Resistive Switching Test Circuit & Waveforms

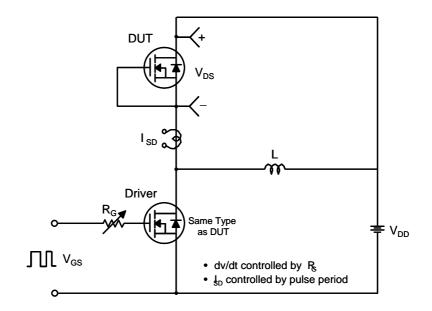


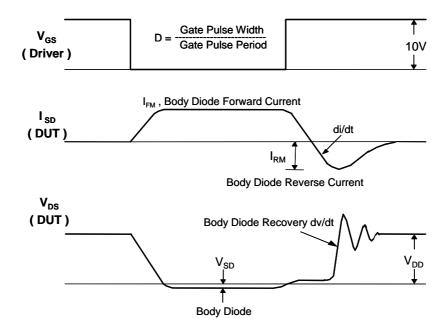
Unclamped Inductive Switching Test Circuit & Waveforms





Peak Diode Recovery dv/dt Test Circuit & Waveforms

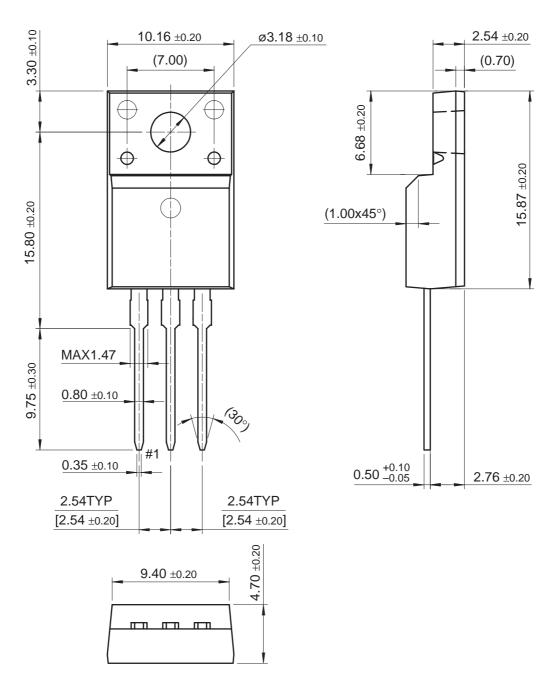




Forward Voltage Drop

Package Dimensions

TO-220F



Dimensions in Millimeters





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